Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/718,738	CHEN ET AL.	
Examiner	Art Unit	
DANIFI G MARIAM	2625	

SEARCHED				
Class	Subclass	Date	Examiner	
382	118,209,2 18,225,22 6,228,305			
707	3,7	3/16/2006	de	
··································				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<u></u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East-Search	3/16/2006	da
West-Search	3/15/2006	da
IEEE	3/15/2006	de